TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSⅢ)

TPC8112

Lithium Ion Battery Applications Notebook PC Applications Portable Equipment Applications

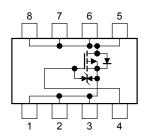
- Small footprint due to small and thin package
- Low drain-source ON resistance: $RDS(ON) = 5.0m\Omega(typ.)$
- High forward transfer admittance: $|Y_{fs}| = 31 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = -10 \,\mu\text{A} \,(\text{max}) \,(V_{DS} = -30 \,\text{V})$
- Enhancement-mode: $V_{th} = -0.8 \text{ to } -2.0 \text{ V (V}_{DS} = -10 \text{ V}, I_D = -1 \text{ mA)}$

Absolute Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-30	V	
Drain-gate voltage (Ro	$g_{S} = 20 \text{ k}\Omega$	V_{DGR}	-30	V	
Gate-source voltage		V _{GSS}	±20	٧	
Drain current	DC (Note 1)	ΙD	-13	Α	
	Pulse (Note 1)	I _{DP}	-52	A	
Drain power dissipatio	n (t = 10 s) (Note 2a)	P_{D}	1.9	W	
Drain power dissipatio	n (t = 10 s) (Note 2b)	P _D	1.0	W	
Single pulse avalanche	e energy (Note 3)	E _{AS}	219	mJ	
Avalanche current		I _{AR}	-13	Α	
Repetitive avalanche (N	energy ote 2a) (Note 4)	E _{AR}	0.19	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55 to 150	°C	

Weight: 0.080 g (typ.)

Circuit Configuration



Note: (Note 1), (Note 2), (Note 3) and (Note 4): See the next page.

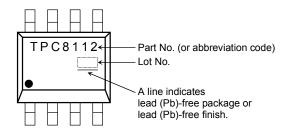
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Please handle with caution.

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	65.8	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	125	°C/W

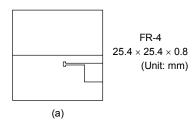
Marking (Note 5)

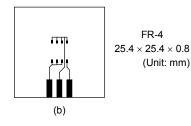


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:

(a) Device mounted on a glass-epoxy board (b) Device mounted on a glass-epoxy board (b)





Note 3: $V_{DD} = -24~V,~T_{ch} = 25^{\circ}C$ (initial), L = 1.0 mH, R_G = 25 $\Omega,~I_{AR} = -13~A$

Note 4: Repetitive rating: pulse width limited by maximum channel temperature

Note 5: • on lower left of the marking indicates Pin 1.



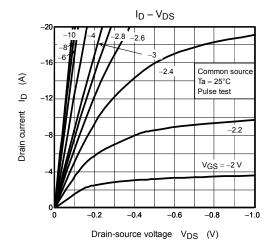
Electrical Characteristics (Ta = 25°C)

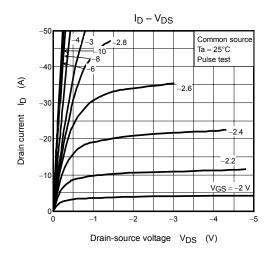
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cut-OFF current		I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	-10	μА
Drain-source breakdown voltage		V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$ -30		_	_	V
		V (BR) DSX	$I_D = -10$ mA, $V_{GS} = 20$ V	-15	_		V
Gate threshold vol	tage	V_{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-0.8	_	-2.0	V
Drain-source ON resistance		Pro (OVI)	$V_{GS} = -4 \text{ V}, I_D = -6.5 \text{ A}$	_	9.0	14	- mΩ
		R _{DS} (ON)	$V_{GS} = -10 \text{ V}, I_D = -6.5 \text{ A}$	_	5.0	6.0	
Forward transfer admittance		Y _{fs}	$V_{DS} = -10 \text{ V}, I_D = -6.5 \text{ A}$	15.5	31	_	S
Input capacitance		C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	5880	_	pF
Reverse transfer capacitance		C _{rss}		_	1000	_	
Output capacitance		Coss		_	1050	_	
Switching time	Rise time	t _r	V_{CS} 0 V Γ $I_D = -6.5 \text{ A}$	_	11	_	
	Turn-ON time	t _{on}	V _{GS} -10 V I _D = -6.5 A C C C C C C C C C C C C C C C C C C	_	22	_	- ns
	Fall time	t _f	4.7.5 4.7.5 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1	_	110	_	
	Turn-OFF time	t _{off}	$V_{DD} \simeq -15 \text{ V}$ Duty \leq 1%, $t_W = 10 \mu\text{s}$	_	395	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq -24 \text{ V, } V_{GS} = 10 \text{ V,}$ $I_{D} = -13 \text{ A}$		130	_	nC
Gate-source charge 1		Q _{gs1}		_	10	_	
Gate-drain ("miller") charge		Q _{gd}		_	30	_	

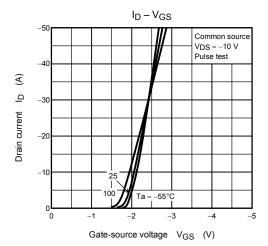
Source-Drain Ratings and Characteristics (Ta = 25°C)

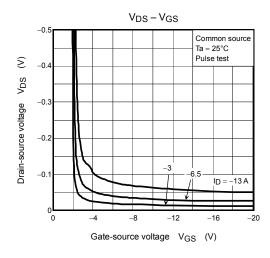
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Drain reverse current	Pulse	(Note 1)	I _{DRP}	_	_	_	-52	А
Forward voltage (diode)		V _{DSF}	$I_{DR} = -13 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	1.2	V	

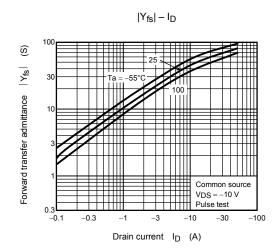
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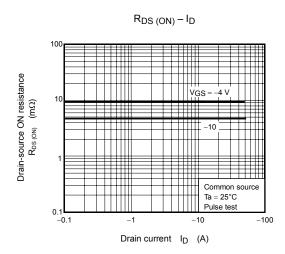




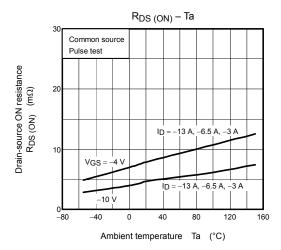


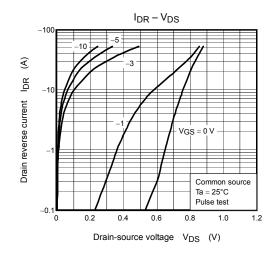


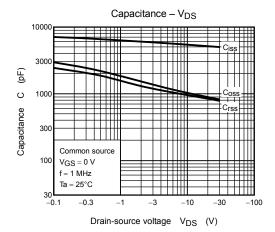


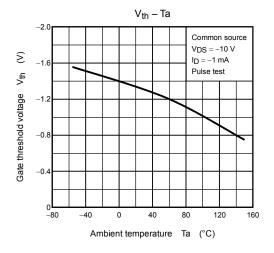


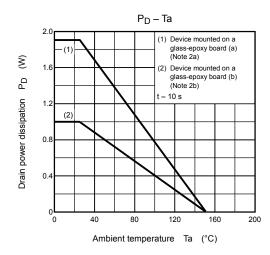
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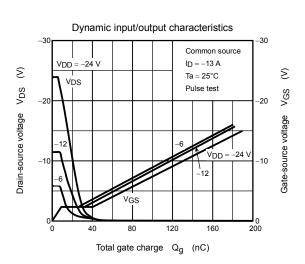


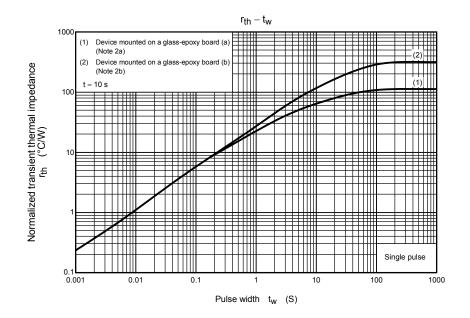


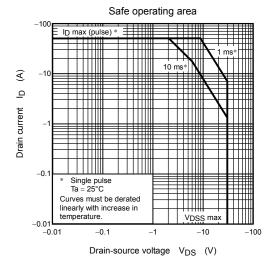












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